FABRICATION OF POROUS SILICON NANOSTUCTURES CHEMICAL SENSOR

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ABSTRACT

FABRICATION OF POROUS SILICON NANOSTRUCTURES CHEMICAL SENSOR

Porous Silicon Nanostructures (PSiN) was prepared by electrochemical etching using ptype Si wafer substrate with constant current density, 20 mA/cm². Ethanoic hydrofluoric acid (HF) 48% electrolyte and ethanol (C_2H_5OH) at ratio 1:1 electrolyte was used. The sample was characterized by using Photoluminescence (PL) spectrum. Porous silicon nanostructures (PSiN) chemical sensor was fabricated by using sputtering technique (gold) to prepare metal contact. This metal was being prepared on the samples as an electrode of sensor and increase sensitivity of sensor. Finally, sample was tested with potassium phosphate (K_2HO_4) at different concentration under *I-V* system.

The result shows that when the potassium phosphate diffuses into a pore, the resistance of porous silicon nanostructures (PSiN) was decreased drastically at about 81.82%. It was also found that the resistance became stable at certain point after solution dropped. Resistance (average) of PSiN decrease with increase of chemical solution concentration dropped. So it concluded that the porous silicon nanostructures sensor is able to detecting the chemical solution.

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CHAPTER 1

INTRODUCTION

1.0 Introduction

Porous Silicon (PSi) is a form of the chemical element silicon which has an introduced nanoporous holes in its microstructure, rendering a large surface to volume ratio in the order of 500m²/cm³. Silicon is widely used in semiconductors because it remains a semiconductor at higher temperatures than the semiconductor germanium and because its native oxide is easily grown in a furnace and forms a better semiconductor/dielectric interface than any other material. Fabrication of porous silicon may range from its initial formation through stain-etching or anodization cell, drying and storage of porous silicon and surface modification needed. In this project, porous silicon is produced by electrochemical dissolution of crystalline silicon in a HF based electrolyte. The amount of material etched from the substrate surface can range from 20 to 90% and layer characterized by a wide range of porosity are obtained.

The resulting structure consists of pores alternating with crystalline silicon rods attached to a crystalline silicon substrate. Large internal surface areas of pores are sensitive to the presence of charged molecules, which can be exploited for sensor development. The physical layer structure of the porous sensors has been

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